

Title (en)
ARRANGEMENT AND METHOD FOR MEASURING A TEMPERATURE

Title (de)
ANORDNUNG UND VERFAHREN ZUM MESSEN EINER TEMPERATUR

Title (fr)
PROCEDE ET SYSTEME POUR MESURER UNE TEMPERATURE

Publication
EP 0958656 A1 19991124 (DE)

Application
EP 98908009 A 19980129

Priority
• DE 19704861 A 19970210
• EP 9800469 W 19980129

Abstract (en)
[origin: WO9835440A1] The invention relates to an arrangement and method for measuring the temperature of a component, in particular of a contactless switch, whereby a transistor or diode is used as a temperature sensor.

IPC 1-7
H03K 17/08

IPC 8 full level
G01K 7/01 (2006.01); **H01L 23/34** (2006.01); **H03K 17/08** (2006.01); **H03K 17/082** (2006.01); **H02H 5/04** (2006.01)

CPC (source: EP US)
G01K 7/01 (2013.01 - EP US); **H01L 23/34** (2013.01 - EP US); **H03K 17/0822** (2013.01 - EP US); **H01L 2924/0002** (2013.01 - EP US); **H02H 5/044** (2013.01 - EP US); **H03K 2017/0806** (2013.01 - EP US)

Citation (search report)
See references of WO 9835440A1

Designated contracting state (EPC)
DE ES FR GB IT SE

DOCDB simple family (publication)
WO 9835440 A1 19980813; DE 19745040 A1 19980820; DE 19745040 C2 20030327; EP 0958656 A1 19991124; JP 2000513816 A 20001017; US 6504697 B1 20030107; WO 9835441 A1 19980813

DOCDB simple family (application)
EP 9800469 W 19980129; DE 19745040 A 19970210; EP 9800357 W 19980123; EP 98908009 A 19980129; JP 53371698 A 19980129; US 36710499 A 19991208